# Application/Control No. O9/844,855 Examiner Douglas W Owens Applicant(s)/Patent Under Reexamination SHI ET AL. Art Unit Page 1 of 1

# Notice of References Cited

### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
Х	Α	US-5,026,816	06-1991	Keehan, Donald J.	528/94
X	В	US-6,180,696	01-2001	Wong et al.	523/457
	С	US-		·	
	D	US			
	Ε	US-		·	
,	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
X	N	JP361112086A	05-1986	Japan	Inokuchi et al.	428/392
	0					
	Р					
	Q					
	R					
	s					
	Т					

# **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	٧						
	w						
	х						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.